

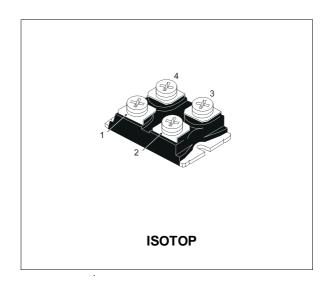
# ESM6045AV

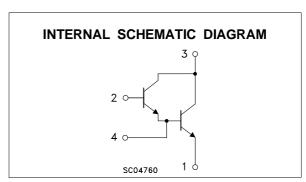
# NPN DARLINGTON POWER MODULE

- HIGH CURRENT POWER BIPOLAR MODULE
- VERY LOW Rth JUNCTION CASE
- SPECIFIED ACCIDENTAL OVERLOAD AREAS
- FULLY INSULATED PACKAGE (UL COMPLIANT)
- EASY TO MOUNT
- LOW INTERNAL PARASITIC INDUCTANCE

#### **INDUSTRIAL APPLICATIONS:**

- MOTOR CONTROL
- SMPS & UPS
- WELDING EQUIPMENT





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CEV</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = -5 V) 1000		V
V <sub>CEO(sus)</sub>	Collector-Emitter Voltage (I <sub>B</sub> = 0)	450	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0) 7		V
Ic	Collector Current	72	А
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> = 10 ms)	108	Α
Ι <sub>Β</sub>	Base Current	8	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> = 10 ms)	16	Α
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	250	W
V <sub>isol</sub>	Insulation Withstand Voltage (RMS) from All Four Terminals to Exernal Heatsink	2500	V
T <sub>stg</sub>	Storage Temperature	-55 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

September 2003 1/7

#### THERMAL DATA

Rt	hj-case	Thermal Resistan	e Junction-case	Max	0.5	°C/W
F	R <sub>thc-h</sub>	Thermal Resistan	e Case-heatsink With Conductive			
		Grease Applied		Max	0.05	°C/W

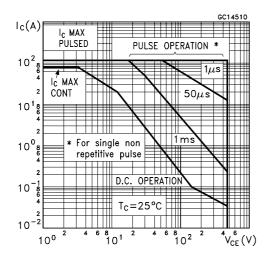
## **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>CER</sub> #	Collector Cut-off Current ( $R_{BE} = 5 \Omega$ )	V <sub>CE</sub> = V <sub>CEV</sub> V <sub>CE</sub> = V <sub>CEV</sub> T <sub>j</sub> = 100 °C			1.5 22	mA mA
I <sub>CEV</sub> #	Collector Cut-off Current (V <sub>BE</sub> = -5)	V <sub>CE</sub> = V <sub>CEV</sub> V <sub>CE</sub> = V <sub>CEV</sub> T <sub>j</sub> = 100 °C			1 15	mA mA
I <sub>EBO</sub> #	Emitter Cut-off Current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 5 V			1	mA
V <sub>CEO(SUS)</sub> *	Collector-Emitter Sustaining Voltage (I <sub>B</sub> = 0)	$I_C = 0.2 \text{ A}$ L = 25 mH $V_{clamp} = 450 \text{ V}$	450			V
h <sub>FE</sub> *	DC Current Gain	I <sub>C</sub> = 60 A V <sub>CE</sub> = 5 V		150		
VCE(sat)*	Collector-Emitter Saturation Voltage	$I_{C} = 50 \text{ A}$ $I_{B} = 1 \text{ A}$ $I_{C} = 50 \text{ A}$ $I_{B} = 1 \text{ A}$ $I_{j} = 100 ^{\circ}\text{C}$ $I_{C} = 60 \text{ A}$ $I_{B} = 2.4 \text{ A}$ $I_{C} = 60 \text{ A}$ $I_{B} = 2.4 \text{ A}$ $I_{C} = 60 \text{ A}$		1.2 1.6 1.3 1.55	2	V V V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	$I_C = 60 \text{ A}$ $I_B = 2.4 \text{ A}$ $I_C = 60 \text{ A}$ $I_B = 2.4 \text{ A}$ $I_j = 100 ^{\circ}\text{C}$		2.1 2.15	3	V V
di <sub>C</sub> /dt	Rate of Rise of On-state Collector	$V_{CC} = 300 \text{ V}$ $R_C = 0$ $t_p = 3 \mu s$ $I_{B1} = 3.6 \text{ A}$ $T_j = 100  ^{\circ}\text{C}$	450	500		A/μs
V <sub>CE</sub> (3 μs)••	Collector-Emitter Dynamic Voltage	$V_{CC} = 300 \text{ V}$ $R_C = 5 \Omega$ $I_{B1} = 3.6 \text{ A}$ $T_j = 100 ^{\circ}\text{C}$		4	7	V
V <sub>CE</sub> (5 μs)••	Collector-Emitter Dynamic Voltage	$V_{CC} = 300 \text{ V}$ $R_C = 5 \Omega$ $I_{B1} = 3.6 \text{ A}$ $T_j = 100 ^{\circ}\text{C}$		2.5	4	V
t <sub>s</sub> t <sub>f</sub> t <sub>c</sub>	Storage Time Fall Time Cross-over Time	$I_{C} = 60 \text{ A}  V_{CC} = 50 \text{ V}$ $V_{BB} = -5 \text{ V}  R_{BB} = 0.3 \Omega$ $V_{clamp} = 450 \text{ V}  I_{B1} = 2.4 \text{ A}$ $L = 0.04 \text{ mH}  T_{j} = 100 \text{ °C}$		4.6 0.4 1.2	6 0.6 2	μs μs μs
V <sub>CEW</sub>	Maximum Collector Emitter Voltage Without Snubber	$\begin{split} I_{CWoff} &= 72 \text{ A}  I_{B1} = 2.4 \text{ A} \\ V_{BB} &= -5 \text{ V}  V_{CC} = 50 \text{ V} \\ L &= 35 \ \mu\text{H}  R_{BB} = 0.3 \ \Omega \\ T_{j} &= 125 \ ^{o}\text{C} \end{split}$	450			V

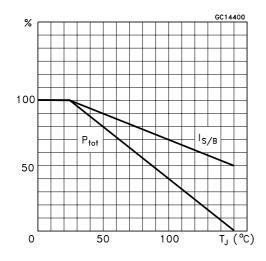
<sup>\*</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 % # See test circuits in databook introduction

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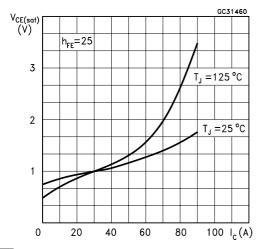
#### Safe Operating Areas



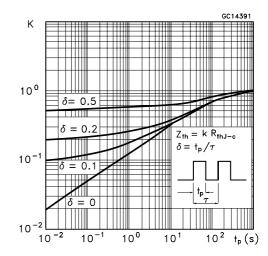
#### **Derating Curve**



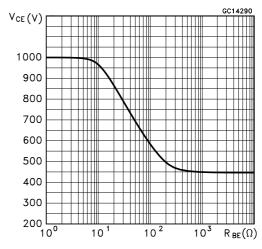
#### Collector Emitter Saturation Voltage



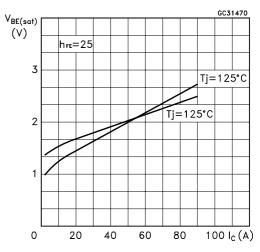
#### Thermal Impedance



# Collector-emitter Voltage Versus base-emitter Resistance

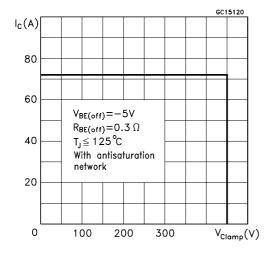


#### Base-Emitter Saturation Voltage

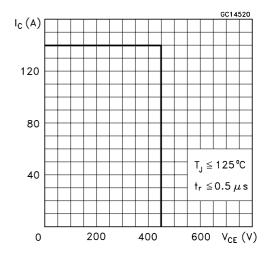


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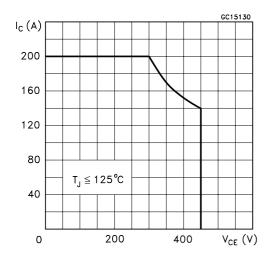
#### Reverse Biased SOA



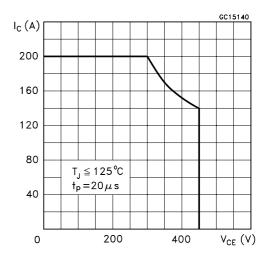
#### Foward Biased SOA



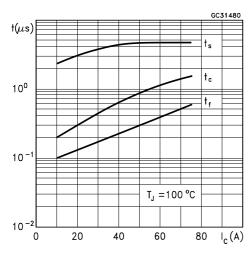
#### Reverse Biased AOA



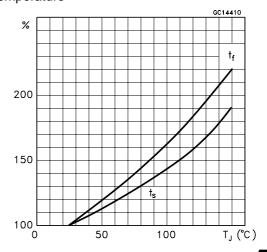
Forward Biased AOA



#### Switching Times Inductive Load

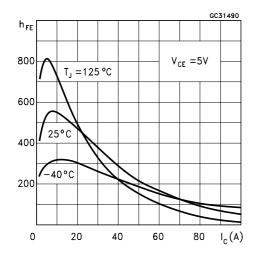


Switching Times Inductive Load Versus Temperature

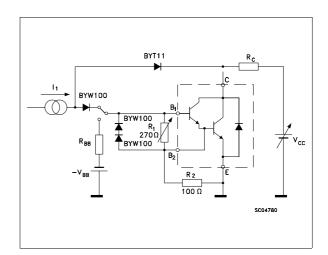


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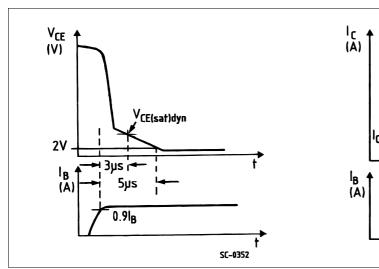
#### Dc Current Gain

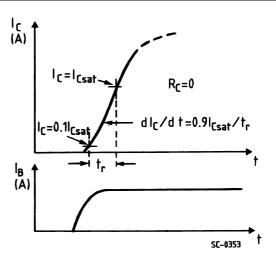


Turn-on Switching Test Circuit

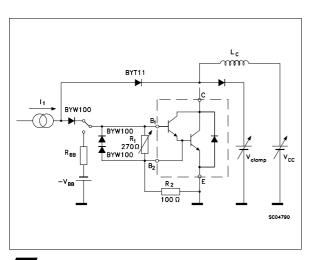


Turn-on Switching Waveforms

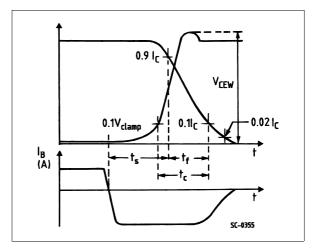




Turn-off Switching Test Circuit

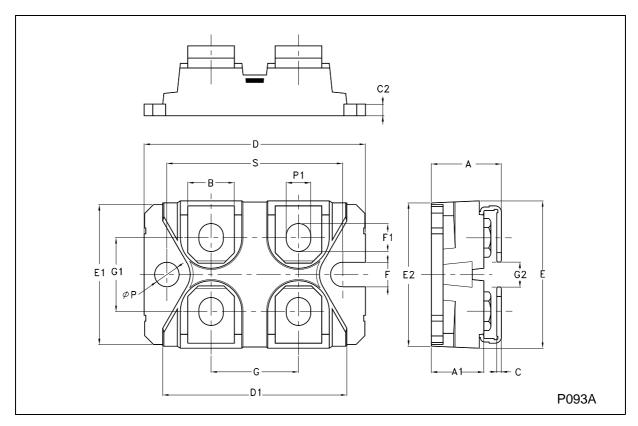


Turn-off Switching Waveforms



### **ISOTOP MECHANICAL DATA**

DIM.	mm		inch			
DIN.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	11.8		12.2	0.465		0.480
A1	8.9		9.1	0.350		0.358
В	7.8		8.2	0.307		0.322
С	0.75		0.85	0.029		0.033
C2	1.95		2.05	0.076		0.080
D	37.8		38.2	1.488		1.503
D1	31.5		31.7	1.240		1.248
Е	25.15		25.5	0.990		1.003
E1	23.85		24.15	0.938		0.950
E2		24.8			0.976	
G	14.9		15.1	0.586		0.594
G1	12.6		12.8	0.496		0.503
G2	3.5		4.3	0.137		1.169
F	4.1		4.3	0.161		0.169
F1	4.6		5	0.181		0.196
Р	4		4.3	0.157		0.169
P1	4		4.4	0.157		0.173
S	30.1		30.3	1.185		1.193



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